查询RMPA2265供应商

FAIRCHILD SEMICONDUCTOR®

December 2004

RMPA2265

Dual Band WCDMA Power Amplifier Module
1850 to 1910 MHz and 1920 to 1980 MHz

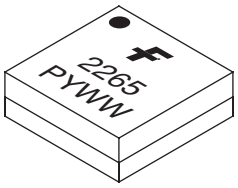
General Description

The RMPA2265 power amplifier module (PAM) is designed for WCDMA applications in both the 1850–1910 and 1920–1980 MHz bands. The 2 stage PAM is internally matched to 50Ω to minimize the use of external components and features a low-power mode to reduce standby current and DC power consumption during peak phone usage. High power-added efficiency and excellent linearity are achieved using Fairchild's InGaP/GaAs Heterojunction Bipolar Transistor (HBT) process.

Features

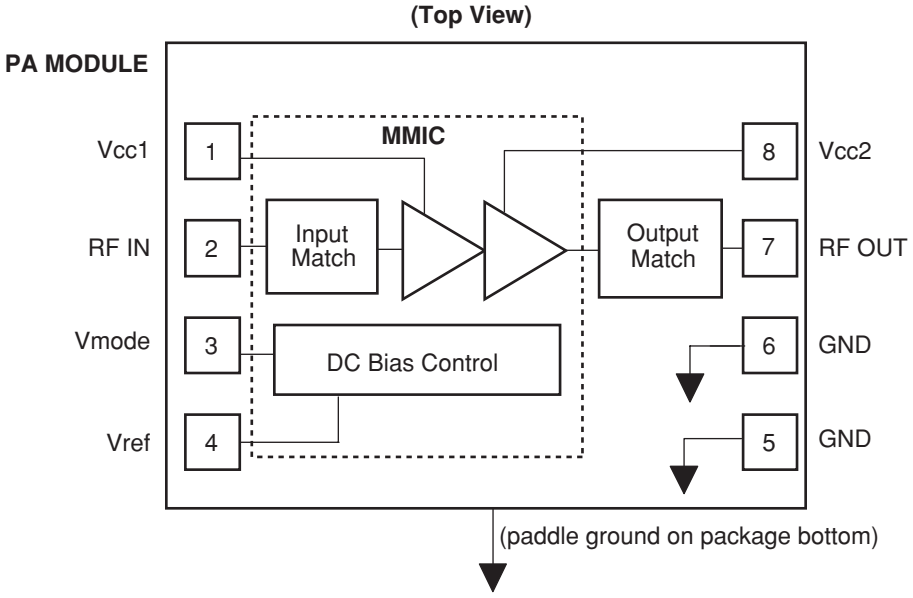
- Single positive-supply operation and low power and shutdown modes
- 42% WCDMA efficiency at +28 dBm average output power 1920–1980 MHz
- 39% WCDMA efficiency at 27.5 dBm average output power 1850–1910 MHz
- Meets UMTS/WCDMA performance requirements in both UMTS bands
- Compact, low-profile package–(3.0 x 3.0 x 1.0 mm nominal)
- Internally matched to 50Ω and DC blocked RF input/output

Device (3 x 3 x 1mm)



Functional Block Diagram

(Top View)



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Absolute Ratings [1]

Symbol	Parameter	Ratings	Units
V_{CC1}, V_{CC2}	Supply Voltages	5.0	V
V_{REF}	Reference Voltage	2.6 to 3.5	V
V_{MODE}	Power Control Voltage	3.5	V
P_{IN}	RF Input Power	+10	dBm
T_{STG}	Storage Temperature	-55 to +150	°C

Note:
1: No permanent damage with only one parameter set at extreme limit. Other parameters set to typical values.

Electrical Characteristics (1920 to 1980 MHz)[1]

Symbol	Parameter	Comments	Min	Typ	Max	Units
f	Operating Frequency		1920		1980	MHz
WCDMA Operation						
Gp	Power Gain	Po = +28dBm, Vmode = 0V	26	28		dB
		Po = +16dBm, Vmode ≥ 2.0V		26		dB
Po	Linear Output Power	Vmode = 0V	28			dBm
		Vmode ≥ 2.0V	16			dBm
PAEd	PAEd (digital) @ +28dBm	Vmode = 0V		42		%
	PAEd (digital) @ +16dBm	Vmode ≥ 2.0V		9		%
	PAEd (digital) @ +16dBm	Vmode ≥ 2.0V, Vcc = 1.4V		25		%
Itot	High Power Total Current	Po = +28dBm, Vmode = 0V		440		mA
	Low Power Total Current	Po = +16dBm, Vmode = 2.0V		120		mA
	Adjacent Channel Leakage Ratio					
ACLR1	±5.00MHz Offset 1920–1980 MHz	Po = +28dBm, Vmode = 0V		-40		dBc
		Po = +16dBm, Vmode ≥ 2.0V		-42		dBc
ACLR2	±10.00MHz Offset 1920–1980 MHz	Po = +28dBm, Vmode = 0V		-54		dBc
		Po = +16dBm, Vmode ≥ 2.0V		-66		dBc
General Characteristics						
VSWR	Input Impedance			2.0:1		
NF	Noise Figure			4		dB
Rx No	Receive Band Noise Power	Po ≤ +28dBm, 2110 to 2170 MHz		-139		dBm/Hz
2fo – 5fo	Harmonic Suppression	Po ≤ +28dBm			-50	dBc
S	Spurious Outputs[2, 3]	Load VSWR ≤ 5.0:1			-60	dBc
	Ruggedness with Load Mismatch[3]	No permanent damage			10:1	
Tc	Case Operating Temperature		-30		85	°C
DC Characteristics						
Iccq	Quiescent Current	Vmode ≥ 2.0V		50		mA
Iref	Reference Current	Po ≤ +28dBm		5		mA
Icc(off)	Shutdown Leakage Current	No applied RF signal		1	5	µA

Notes:
1: All parameters met at T_C = +25°C, V_{CC} = +3.4V, V_{REF} = 2.85V and load VSWR ≤ 1.2:1, unless otherwise noted.
2: All phase angles
3: Guaranteed by design

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Electrical Characteristics (1850 to 1910 MHz)[1]

Symbol	Parameter	Comments	Min	Typ	Max	Units
f	Operating Frequency		1850		1910	MHz
WCDMA Operation						
Gp	Power Gain	Po = +27.5dBm, Vmode = 0V	26	28		dB
		Po = +16dBm, Vmode ≥ 2.0V		26		dB
Po	Linear Output Power	Vmode = 0V	27.5			dBm
		Vmode ≥ 2.0V	16			dBm
PAEd	PAEd (digital) @ +27.5dBm	Vmode = 0V		39		%
	PAEd (digital) @ +16dBm	Vmode ≥ 2.0V		9		%
	PAEd (digital) @ +16dBm	Vmode ≥ 2.0V, Vcc = 1.4V		25		%
Itot	High Power Total Current	Po = +27.5dBm, Vmode = 0V		420		mA
	Low Power Total Current	Po = +16dBm, Vmode = 2.0V		120		mA
	Adjacent Channel Leakage Ratio					
ACLR1	±5.00MHz Offset 1850–1910 MHz	Po = +27.5dBm, Vmode = 0V		-40		dBc
		Po = +16dBm, Vmode ≥ 2.0V		-42		dBc
ACLR2	±10.00MHz Offset 1850–1910 MHz	Po = +27.5dBm, Vmode = 0V		-54		dBc
		Po = +16dBm, Vmode ≥ 2.0V		-66		dBc
General Characteristics						
VSWR	Input Impedance			2.0:1		
NF	Noise Figure			4		dB
Rx No	Receive Band Noise Power	Po ≤ +27.5dBm, 2110 to 2170 MHz		-139		dBm/Hz
2fo – 5fo	Harmonic Suppression	Po ≤ +27.5dBm			-50	dBc
S	Spurious Outputs[2, 3]	Load VSWR ≤ 5.0:1			-60	dBc
	Ruggedness with Load Mismatch[3]	No permanent damage			10:1	
Tc	Case Operating Temperature		-30		85	°C
DC Characteristics						
Iccq	Quiescent Current	Vmode ≥ 2.0V		50		mA
Iref	Reference Current	Po ≤ +27.5dBm		5		mA
Icc(off)	Shutdown Leakage Current	No applied RF signal		1	5	µA

Notes:
1: All parameters met at T_C = +25°C, V_{CC} = +3.4V, V_{REF} = 2.85V and load VSWR ≤ 1.2:1, unless otherwise noted.
2: All phase angles
3: Guaranteed by design

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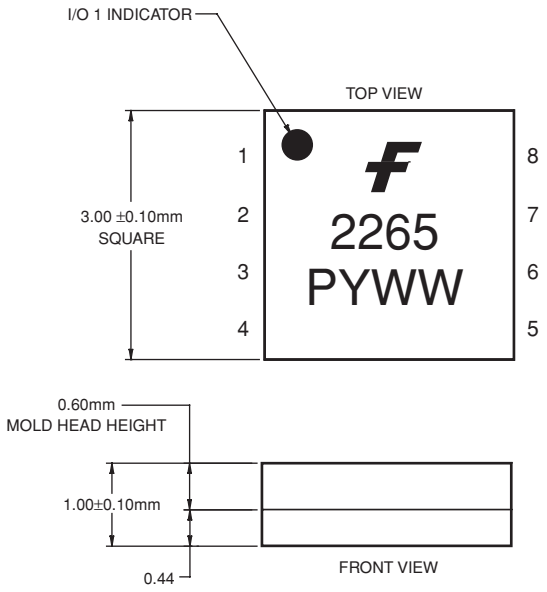
Recommended Operating Conditions

Symbol	Parameter	Min	Typ	Max	Units
f	Operating Frequency	1850		1980	MHz
V_{CC1}, V_{CC2}	Supply Voltage	3.0	3.4	4.2	V
V_{REF}	Reference Voltage				
	Operating	2.7	2.85	3.1	V
	Shutdown	0		0.5	V
V_{MODE}	Bias Control Voltage				
	Low-Power	1.8	2.0	3.0	V
	High-Power	0		0.5	V
P_{OUT}	Linear Output Power (low-power)			+16	dBm
	1920–1980 MHz (high power)			+28	dBm
	1850–1910 MHz (high power)			+27.5	dBm
T_C	Case Operating Temperature	-30		+85	°C

Package Outline



Signal Description

Pin #	Signal Name	Description
1	VCC1	Supply Voltage to Input Stage
2	RF In	RF Input Signal
3	VMODE	High Power/Low Power Switch
4	VREF	Reference Voltage
5	GND	Ground
6	GND	Ground
7	RF Out	RF Output Signal
8	VCC2	Supply Voltage to Output Stage
9	GND	Ground

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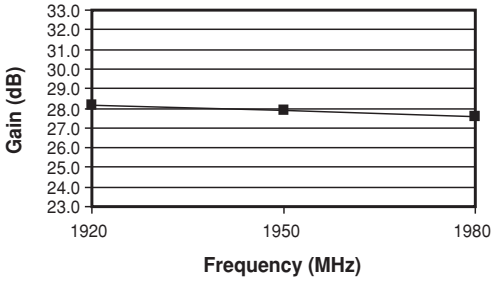
Performance Data: 1920 to 1980 MHz

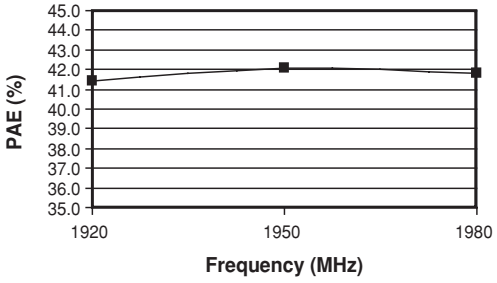
RMPA2265 3x3 WCDMA PA

Vcc=3.4V, Vref=2.85V, Vmode=0V, Pout=28dBm



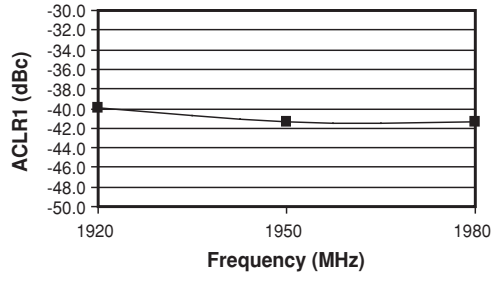
RMPA2265 3x3 WCDMA PA

Vcc=3.4V, Vref=2.85V, Vmode=0V, Pout=28dBm



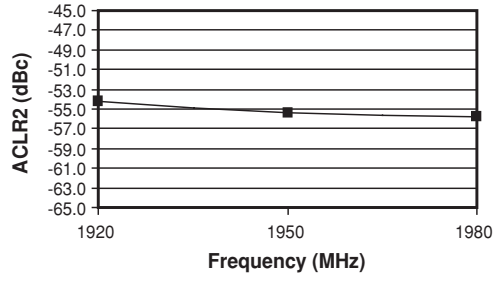
RMPA2265 3x3 WCDMA PA

Vcc=3.4V, Vref=2.85V, Vmode=0V, Pout=28dBm



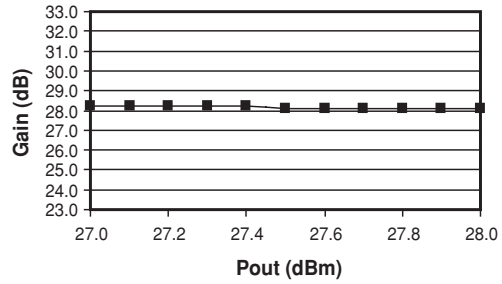
RMPA2265 3x3 WCDMA PA

Vcc=3.4V, Vref=2.85V, Vmode=0V, Pout=28dBm



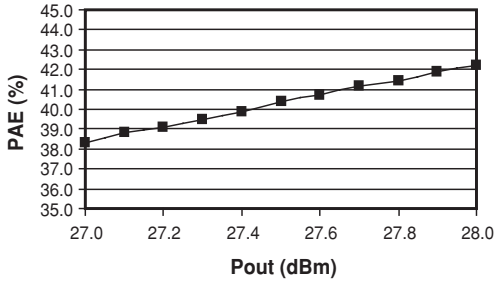
RMPA2265 3x3 WCDMA PA , Freq=1.95GHz

Vcc=3.4V, Vref=2.85V, Vmode=0V



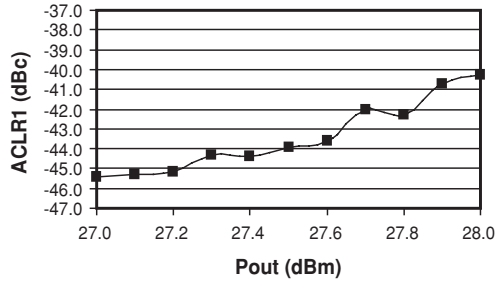
RMPA2265 3x3 WCDMA PA , Freq=1.95GHz

Vcc=3.4V, Vref=2.85V, Vmode=0V



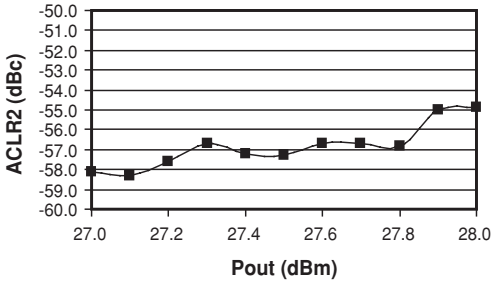
RMPA2265 3x3 WCDMA PA , Freq=1.95GHz

Vcc=3.4V, Vref=2.85V, Vmode=0V



RMPA2265 3x3 WCDMA PA , Freq=1.95GHz

Vcc=3.4V, Vref=2.85V, Vmode=0V



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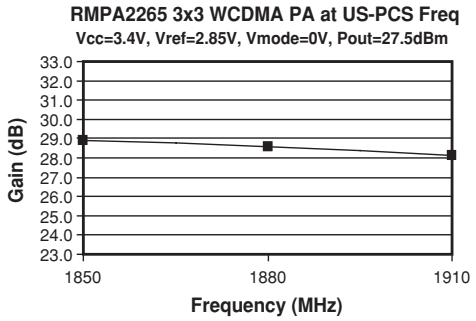
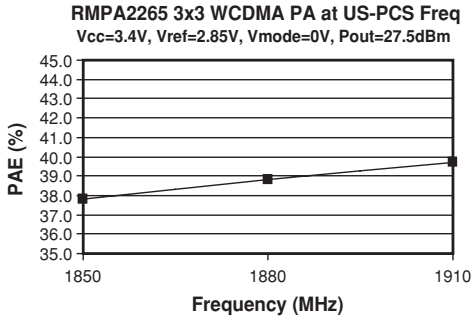
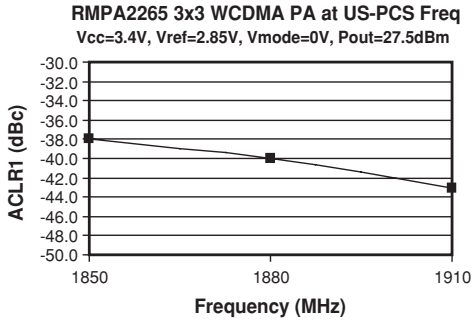
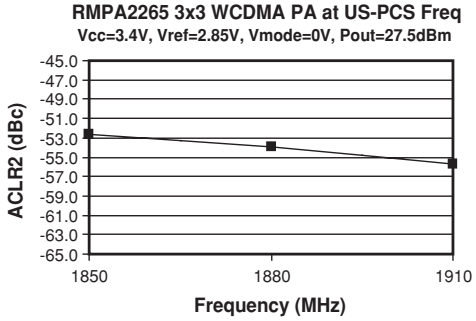
Performance Data: 1850 to 1910 MHz









Efficiency Improvement Applications

In addition to high-power/low-power bias modes, the efficiency of the PA module can be significantly increased at backed-off RF power levels by dynamically varying the supply voltage (Vcc) applied to the amplifier. Since mobile handsets and power amplifiers frequently operate at 10–20 dB back-off, or more, from maximum rated linear power, battery life is highly dependent on the DC power consumed at antenna power levels in the range of 0 to +16dBm. The reduced demand on transmitted RF power allows the PA supply voltage to be reduced for improved efficiency, while still meeting linearity requirements for WCDMA modulation with excellent margin. High-efficiency DC-DC converters are now available to implement switched-voltage operation.

With the PA module in low-power mode (Vmode = 2.0V) at +16dBm output power and supply voltages reduced from 3.4V nominal down to 1.2V, power-added efficiency is more than doubled from 9 percent to 25 percent (Vcc = 1.2V) while maintaining a typical ACLR1 of -40dBc and ACLR2 of less than -54 dBc. Operation at even lower levels of Vcc supply voltage are possible with a further restriction on the maximum RF output power.

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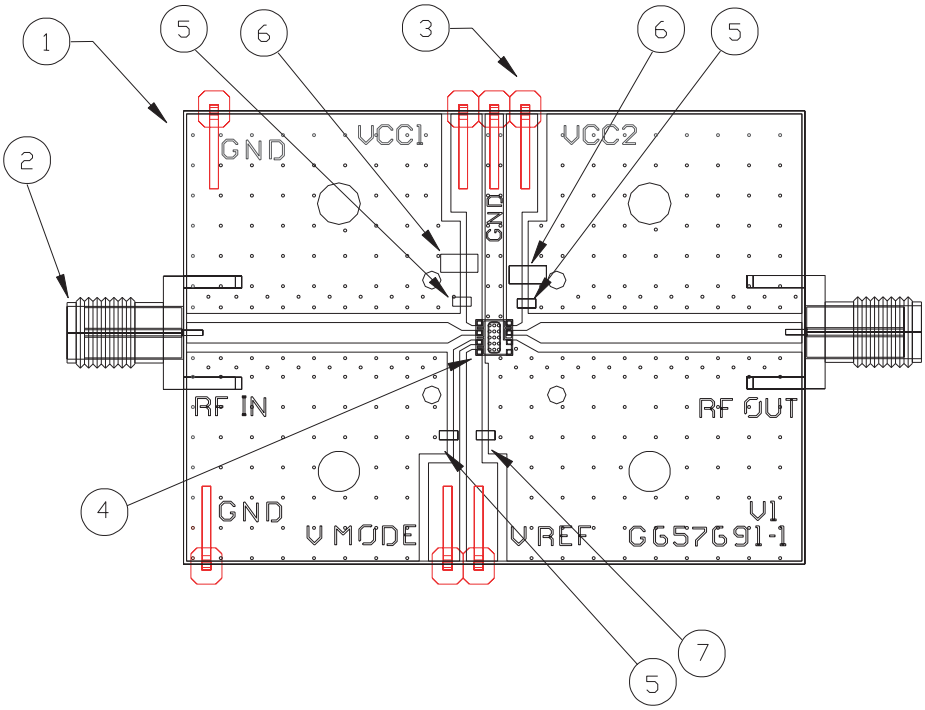
Evaluation Board Layout



Materials List

Qty	Item No.	Part Number	Description	Vendor
1	1	G657691-1 V1	PC Board	Fairchild
2	2	#142-0701-841	SMA Connector	Johnson
7	3	#2340-5211TN	Terminals	3M
Ref	4		Assembly, RMPA2265	Fairchild
3	5	GRM39X7R102K50V	1000pF Capacitor (0603)	Murata
3	5 (Alt)	ECJ-1VB1H102K	1000pF Capacitor (0603)	Panasonic
2	6	C3216X5R1A335M	3.3µF Capacitor (1206)	TDK
1	7	GRM39Y5V104Z16V	0.1µF Capacitor (0603)	Murata
1	7 (Alt)	ECJ-1VB1C104K	0.1µF Capacitor (0603)	Panasonic
A/R	8	SN63	Solder Paste	Indium Corp.
A/R	9	SN96	Solder Paste	Indium Corp.

DC Turn On Sequence:

1. VCC1 = VCC2 = 3.4V (typical)

2. VREF = 2.85V (typical)

3. High-Power: VMODE = 0V (Pout > 16dBm)
   Low-Power: VMODE = 2.0V (Pout < 16dBm)

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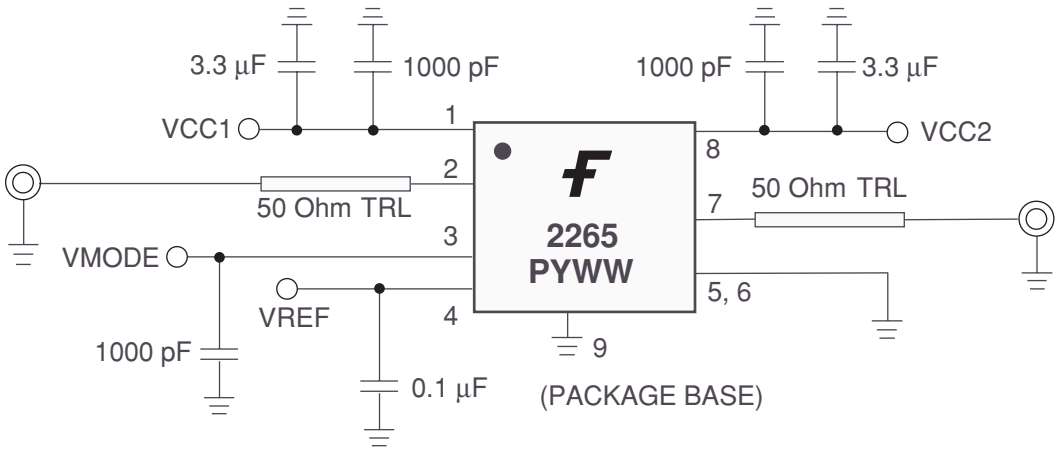
Evaluation Board Schematic



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Applications Information

CAUTION: THIS IS AN ESD SENSITIVE DEVICE.

Precautions to Avoid Permanent Device Damage:

- Cleanliness: Observe proper handling procedures to ensure clean devices and PCBs. Devices should remain in their original packaging until component placement to ensure no contamination or damage to RF, DC and ground contact areas.
- Device Cleaning: Standard board cleaning techniques should not present device problems provided that the boards are properly dried to remove solvents or water residues.
- Static Sensitivity: Follow ESD precautions to protect against ESD damage:
  - A properly grounded static-dissipative surface on which to place devices.
  - Static-dissipative floor or mat.
  - A properly grounded conductive wrist strap for each person to wear while handling devices.
- General Handling: Handle the package on the top with a vacuum collet or along the edges with a sharp pair of bent tweezers. Avoiding damaging the RF, DC, and ground contacts on the package bottom. Do not apply excessive pressure to the top of the lid.
- Device Storage: Devices are supplied in heat-sealed, moisture-barrier bags. In this condition, devices are protected and require no special storage conditions. Once the sealed bag has been opened, devices should be stored in a dry nitrogen environment.

Device Usage:
Fairchild recommends the following procedures prior to assembly.

- Dry-bake devices at 125°C for 24 hours minimum. Note: The shipping trays cannot withstand 125°C baking temperature.
- Assemble the dry-baked devices within 7 days of removal from the oven.
- During the 7-day period, the devices must be stored in an environment of less than 60% relative humidity and a maximum temperature of 30°C
- If the 7-day period or the environmental conditions have been exceeded, then the dry-bake procedure must be repeated.

Solder Materials & Temperature Profile:
Reflow soldering is the preferred method of SMT attachment. Hand soldering is not recommended.

Reflow Profile

- Ramp-up: During this stage the solvents are evaporated from the solder paste. Care should be taken to prevent rapid oxidation (or paste slump) and solder bursts caused by violent solvent out-gassing. A typical heating rate is 1-2°C/sec.
- Pre-heat/soak: The soak temperature stage serves two purposes; the flux is activated and the board and devices achieve a uniform temperature. The recommended soak condition is: 120–150 seconds at 150°C.
- Reflow Zone: If the temperature is too high, then devices may be damaged by mechanical stress due to thermal mismatch or there may be problems due to excessive solder oxidation. Excessive time at temperature can enhance the formation of inter-metallic compounds at the lead/board interface and may lead to early mechanical failure of the joint. Reflow must occur prior to the flux being completely driven off. The duration of peak reflow temperature should not exceed 10 seconds. Maximum soldering temperatures should be in the range 215–220°C, with a maximum limit of 225°C.
- Cooling Zone: Steep thermal gradients may give rise to excessive thermal shock. However, rapid cooling promotes a finer grain structure and a more crack-resistant solder joint. The illustration below indicates the recommended soldering profile.

Solder Joint Characteristics:
Proper operation of this device depends on a reliable void-free attachment of the heat sink to the PWB. The solder joint should be 95% void-free and be a consistent thickness.

Rework Considerations:
Rework of a device attached to a board is limited to reflow of the solder with a heat gun. The device should not be subjected to more than 225°C and reflow solder in the molten state for more than 5 seconds. No more than 2 rework operations should be performed.

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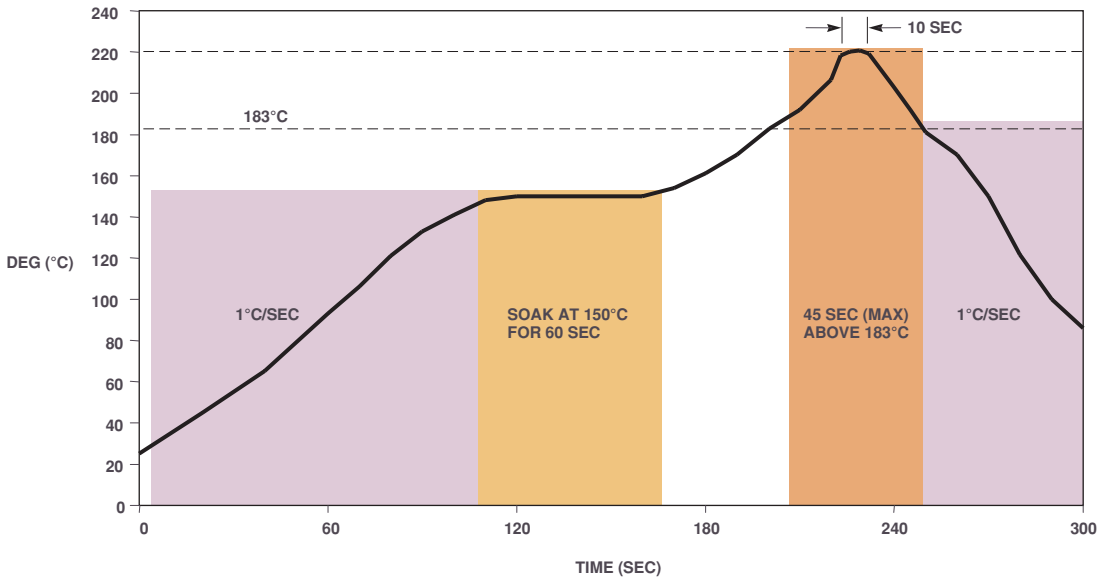
Recommended Solder Reflow Profile



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CROSSVOLT™	GlobalOptoisolator™	MicroFET™	PowerTrench®	SuperSOT™-6
DOME™	GTO™	MicroPak™	QFET®	SuperSOT™-8
EcoSPARK™	HiSeC™	MICROWIRE™	QS™	SyncFET™
E^2CMOS™	I^2C™	MSX™	QT Optoelectronics™	TinyLogic®
EnSigna™	*i-Lo*™	MSXPro™	Quiet Series™	TINYOPTO™
FACT™	ImpliedDisconnect™	OCX™	RapidConfigure™	TruTranslation™
FACT Quiet Series™		OCXPro™	RapidConnect™	UHC™
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The Power Franchise®		OPTOPLANAR™	SILENT SWITCHER®	UniFET™
Programmable Active Droop™		PACMAN™	SMART START™	VCX™

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2. A critical component is any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

PRODUCT STATUS DEFINITIONS

Definition of Terms

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Preliminary	First Production	This datasheet contains preliminary data, and supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice in order to improve design.
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